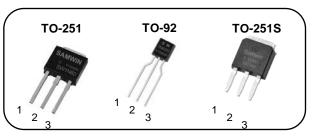


## N-channel Enhancement mode TO-251/TO-92/TO251S MOSFET

#### **Features**

- High ruggedness
- R<sub>DS(ON)</sub> (Typ 6.6Ω)@V<sub>GS</sub>=10V
- Gate Charge (Typ 6.8nC)
- Improved dv/dt Capability
- 100% Avalanche Tested
- Application: Charger



1. Gate 2. Drain 3. Source

# 2 2 3



**BV<sub>DSS</sub>**: 600V

 $R_{DS(ON)}$ : 6.6 $\Omega$ 

I<sub>D</sub> : 1A



# **General Description**

This power MOSFET is produced with advanced technology of SAMWIN. This technology enable power MOSFET to have better characteristics, such as fast switching time, low on resistance, low gate charge and especially excellent avalanche characteristics.

#### **Order Codes**

Item	Sales Type	Marking	Package	Packaging
1	SW I 1N60D	SW1N60D	TO-251	TUBE
2	SW C 1N60D	SW1N60D	TO-92	TAPE
3	SW SI 1N60D	SW1N60D	TO-251S	TUBE

### **Absolute maximum ratings**

Symbol	Parameter			Value	Unit	
Symbol			TO-251	TO-92	TO251S	UIIII
V <sub>DSS</sub>	Drain to Source Voltage			600	V	
	Continuous Drain Current (@T <sub>C</sub> =25°C)			1*	Α	
l <sub>D</sub>	Continuous Drain Current (@T <sub>c</sub> =100°C)			0.63*	Α	
I <sub>DM</sub>	Drain current pulsed	(note 1)		4		Α
$V_{GS}$	Gate to Source Voltage			±30		V
E <sub>AS</sub>	Single pulsed Avalanche Energy	(note 2)		68		mJ
E <sub>AR</sub>	Repetitive Avalanche Energy	(note 1)		8		mJ
dv/dt	Peak diode Recovery dv/dt	(note 3)		5		V/ns
	Total power dissipation (@T <sub>C</sub> =25°C)		65.9	4.2	56.8	W
P <sub>D</sub>	Derating Factor above 25°C		0.53	0.03	0.46	W/°C
$T_{STG},T_{J}$	Operating Junction Temperature & Storage Temperature		{	55 ~ + 15	°C	
TL	Maximum Lead Temperature for soldering purpose, 1/8 from Case for 5 seconds.			300	°C	

<sup>\*.</sup> Drain current is limited by junction temperature.

#### Thermal characteristics

Symbol	Parameter	Value			Unit
		TO-251	TO-92	TO251S	
R <sub>thjc</sub>	Thermal resistance, Junction to case	1.9	30.1	2.2	°C/W
R <sub>thcs</sub>	Thermal resistance, Case to Sink	0.5		0.5	°C/W
$R_{thja}$	Thermal resistance, Junction to ambient	90	113.5	100	°C/W



# **Electrical characteristic** ( $T_C = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Off charact	teristics	•				•
BV <sub>DSS</sub>	Drain to source breakdown voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	600			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown voltage temperature coefficient	I <sub>D</sub> =250uA, referenced to 25°C		0.51		V/°C
,	Drain to source leakage current	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V			1	uA
I <sub>DSS</sub>		V <sub>DS</sub> =480V, T <sub>C</sub> =125°C			50	uA
	Gate to source leakage current, forward	V <sub>GS</sub> =30V, V <sub>DS</sub> =0V	R	2)	100	nA
I <sub>GSS</sub>	Gate to source leakage current, reverse	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V		9	-100	nA
On charact	teristics		A	•	•	•
V <sub>GS(TH)</sub>	Gate threshold voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	2.5		4.5	V
R <sub>DS(ON)</sub>	Drain to source on state resistance	$V_{GS} = 10V, I_D = 0.5A$		6.6	8.5	Ω
Gfs	Forward Transconductance	$V_{DS} = 30 \text{ V}, I_{D} = 0.5 \text{A}$		1		S
Dynamic c	haracteristics					
C <sub>iss</sub>	Input capacitance		3	150		pF
C <sub>oss</sub>	Output capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz		28		
C <sub>rss</sub>	Reverse transfer capacitance			9		
t <sub>d(on)</sub>	Turn on delay time			5		
tr	Rising time	$V_{DS}$ =300V, $I_{D}$ =1A, $R_{G}$ =25 $\Omega$ (note 4,5)		20		ns
t <sub>d(off)</sub>	Turn off delay time			13		
t <sub>f</sub>	Fall time			23.5		
$Q_g$	Total gate charge			6.8		
$Q_{gs}$	Gate-source charge	$V_{DS}$ =480V, $V_{GS}$ =10V, $I_{D}$ =1A (note 4,5)		1.3		nC
$Q_{gd}$	Gate-drain charge			3.7		

#### Source to drain diode ratings characteristicsa

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>S</sub>	Continuous source current	Integral reverse p-n Junction diode in the MOSFET			1	Α
I <sub>SM</sub>	Pulsed source current				4	Α
V <sub>SD</sub>	Diode forward voltage drop.	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			1.35	\ \
T <sub>rr</sub>	Reverse recovery time	I <sub>S</sub> =1A, V <sub>GS</sub> =0V, dI <sub>F</sub> /dt=100A/us		175		ns
Q <sub>rr</sub>	Reverse recovery Charge			1.14		uC

- Repeatitive rating : pulse width limited by junction temperature.
- L = 135mH, I<sub>AS</sub> = 1A, V<sub>DD</sub> = 50V, R<sub>G</sub>=25Ω, Starting T<sub>J</sub> = 25°C I<sub>SD</sub> ≤ 1A, di/dt = 100A/us, V<sub>DD</sub> ≤ BV<sub>DSS</sub>, Staring T<sub>J</sub> =25°C Pulse Test: Pulse Width ≤ 300us, duty cycle ≤ 2%. 2.
- 3.
- 4.
- Essentially independent of operating temperature. 5.

Fig. 1. On-state characteristics

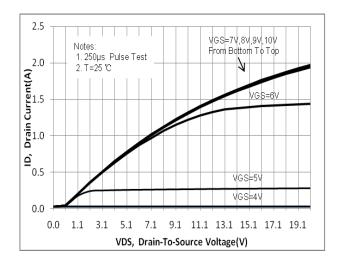


Fig. 3. Gate charge characteristics

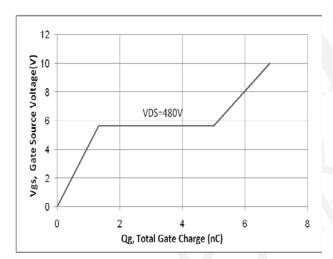


Fig 5. Breakdown Voltage Variation vs. Junction Temperature

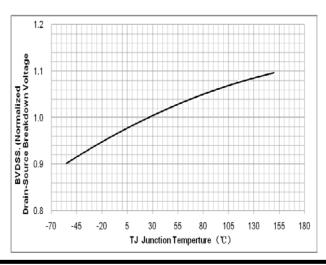


Fig. 2. On-resistance variation vs. drain current and gate voltage

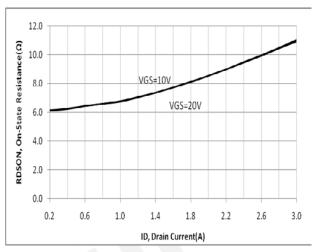


Fig. 4. On state current vs. diode forward voltage

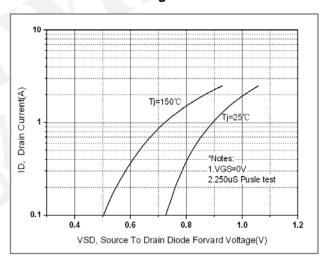


Fig. 6. On resistance variation vs. junction temperature

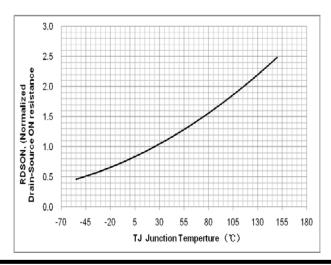


Fig. 7. Maximum safe operating area (TO-251)

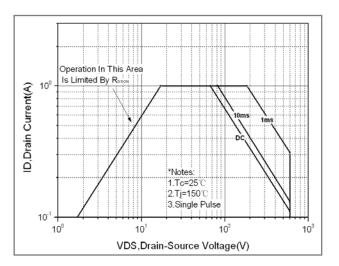


Fig. 9. Maximum safe operating area (TO-92)

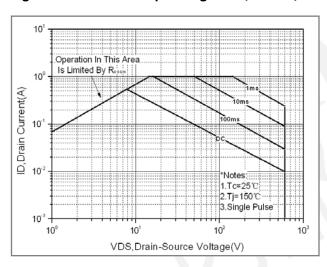


Fig. 11. Maximum safe operating area ( TO-251S )

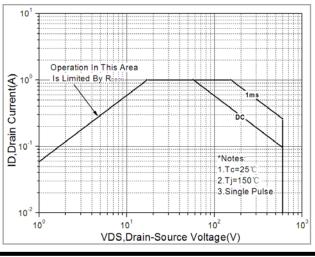


Fig. 8. Transient thermal response curve (TO-251)

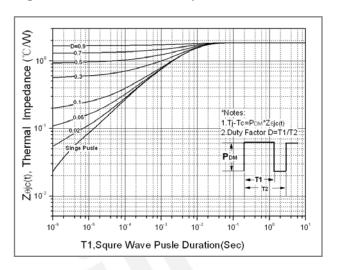


Fig. 10. Transient thermal response curve (TO-92)

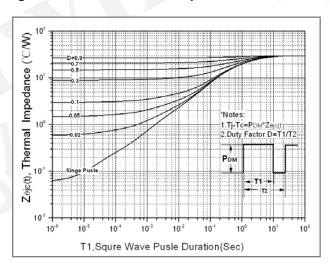


Fig. 12. Transient thermal response curve (TO-251S)

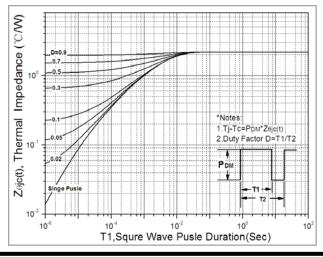


Fig. 13. Capacitance Characteristics

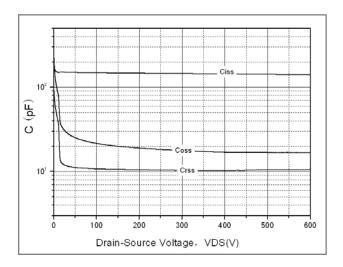


Fig. 14. Gate charge test circuit & waveform

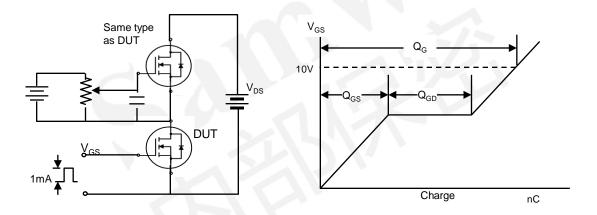


Fig. 15. Switching time test circuit & waveform

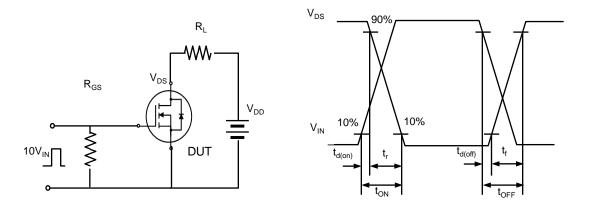




Fig. 16. Unclamped Inductive switching test circuit & waveform

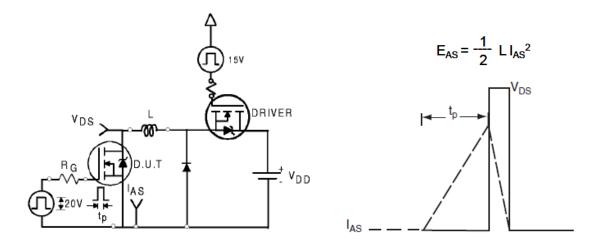
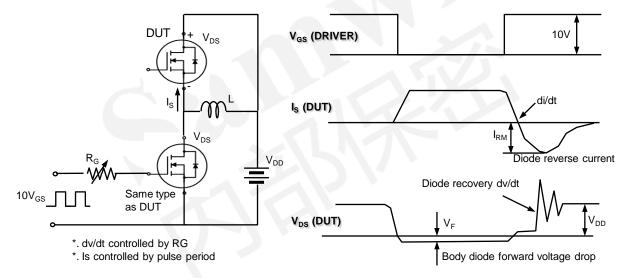


Fig. 17. Peak diode recovery dv/dt test circuit & waveform



#### **DISCLAIRATION:**

- \* All the data&curve within this document was tested in XI'AN SEMIPOWER TESTING&APPLICATION CENTER.
- \* This product has passed the PCT,TC,HTRB,HTGB,HAST,PC and Solderdunk reliability testing.
- \* Qualification Standards can also be found on the Web site (http://www.semipower.com.cn)



\* Any advice, please send your proposal to samwin@samwinsemi.com